Se	arch N	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/627,096	HIRANO ET AL.
Examiner	Art Unit
Brian E. Miller	2627

	SEARCHED		
Class	Subclass	Date	Examiner
360	294.3	5/3/2006	BEM
updated	as above	10/30/2006	BEM

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				
			-	

SEAR (INCLUDING S	CH NOT EARCH S	ES STRATEGY)
		DATE	EXMR
PLUS Search		5/3/2006	ВЕМ